



# High Quality $P$ -Type Mg-Doped $\beta$ -Ga<sub>2</sub>O<sub>3- $\delta$</sub> Films for Solar-Blind Photodetectors

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**Abstract**—The  $(\bar{2}01)$ -oriented Mg-doped  $\beta$ -Ga<sub>2</sub>O<sub>3- $\delta$</sub>  films were grown on (0001)-sapphire substrates by pulsed laser deposition (PLD) at various oxygen partial pressures ( $P_O = 10$ –40 mTorr). The conductivity type of the as-deposited Mg-doped  $\beta$ -Ga<sub>2</sub>O<sub>3- $\delta$</sub>  films is proved to be  $p$ -type according to the transfer characteristic curves of a top-gate field effect transistor (FET) and rectification curves of the Mg-doped/undoped  $\beta$ -Ga<sub>2</sub>O<sub>3- $\delta$</sub>  junction. In addition, the two-terminal solar-blind photodetectors based on Mg-doped  $\beta$ -Ga<sub>2</sub>O<sub>3- $\delta$</sub>  films prepared at  $P_O = 30$  mTorr exhibit a good optoelectrical performance with a low dark current of 0.19 pA at 10 V, a high  $I_{254\text{nm}}/I_{\text{dark}}$  ratio of  $1.3 \times 10^4$ , fast rise ( $\tau_{r1} = 0.035$  s and  $\tau_{r2} = 0.241$  s) and decay ( $\tau_{d1} = 0.022$  s and  $\tau_{d2} = 0.238$  s) times. The present work indicates that the  $p$ -type Mg-doped  $\beta$ -Ga<sub>2</sub>O<sub>3- $\delta$</sub>  films can be used in the third-generation ultraviolet photodetectors.

**Index Terms**—Solar-blind photodetectors, wide bandgap,  $p$ -type Ga<sub>2</sub>O<sub>3- $\delta$</sub>  films, pulsed laser deposition.

## I. INTRODUCTION

As a representatives of the third-generation semiconductors, gallium oxide (Ga<sub>2</sub>O<sub>3</sub>) has five polymorphs:  $\alpha$ ,  $\beta$ ,  $\gamma$ ,  $\delta$ , and  $\epsilon$  [1]–[5]. Among them,  $\beta$ -Ga<sub>2</sub>O<sub>3</sub> is the most stable phase with an intrinsic wide bandgap, high transmittance in

the ultraviolet (UV)-visible-near infrared (NIR) region [6]–[8]. Therefore, it can be widely used in high power devices, UV photodetectors, photoluminescence devices, gas sensors, etc [9]–[14]. It should be emphasized that it is suitable for the application of solar-blind photodetectors ( $\lambda \leq 280$  nm) since  $\beta$ -Ga<sub>2</sub>O<sub>3</sub> has an ultra-wide optical bandgap of about 4.9 eV (253 nm), effectively shielding the influence caused by solar radiation and artificial light sources [15]–[17].

Many efforts have been made to realize  $p$ -type Ga<sub>2</sub>O<sub>3</sub> by doping N, Se, Zn, and Mg elements as acceptor dopants for the applications of optoelectronic and power devices [19]–[26]. Recently, Wu *et al.* grew  $p$ -type N-doped  $\beta$ -Ga<sub>2</sub>O<sub>3</sub> films with Hall hole mobility of  $23.6 \text{ cm}^2 \text{ V}^{-1} \text{ s}^{-1}$  and hole concentration of  $1.56 \times 10^{16} \text{ cm}^{-3}$  for the application of optoelectronic devices [19]. Moreover, the  $p$ -type Zn-doped  $\beta$ -Ga<sub>2</sub>O<sub>3</sub> ultra-wild semiconductors have a higher critical breakdown field (13.2 MV/cm) than SiC (3 MV/cm), GaN (3.3 MV/cm),  $\beta$ -Ga<sub>2</sub>O<sub>3</sub> ( $\sim 8$  MV/cm), and diamond (10 MV/cm) for the application of power electronics [24]. However, it is still a big challenge to achieve a good  $p$ -type conductivity and stability for the third-generation semiconductor  $\beta$ -Ga<sub>2</sub>O<sub>3</sub> due to the strong hole-trapping effect, large acceptor ionization energy, self-compensation effect, and low hole mobility.

Among the acceptors, Mg is predicted to be the most promising candidates of  $p$ -type Ga<sub>2</sub>O<sub>3</sub> due to the lowest formation energy and a relatively shallow acceptor level [25]–[27]. Qian *et al.* obtained weak  $p$ -type Ga<sub>2</sub>O<sub>3</sub> thin films by doping Mg, and their photodetectors have a low dark current (4.1 pA at 10 V), high response (23.8 mA/W), and short decay time (0.02 s) under 254 nm UV light for the solar-blind photodetectors [26]. While the resistance of Mg-doped  $\beta$ -Ga<sub>2</sub>O<sub>3</sub> will be high since Mg serves as compensating acceptors. In addition, the film phase will become  $\epsilon$  from  $\beta$  with increasing the Mg concentration [28]. It is difficult to obtain stable  $p$ -type Mg-doped Ga<sub>2</sub>O<sub>3</sub> with a good conductivity because of the deep level acceptor and self-compensating effect [29]. Fortunately, the pulsed laser deposition (PLD) can be used to prepare  $p$ -type Mg-doped Ga<sub>2</sub>O<sub>3</sub> films at a high deposition temperature and oxygen pressure by inducing oxygen vacancy concentration [30].

In the letter, the crystalline structure, composition, optical response, and optoelectrical properties of the Mg-doped  $\beta$ -Ga<sub>2</sub>O<sub>3- $\delta$</sub>  films prepared by PLD were systematically investigated. It has been found that the present films have a  $(\bar{2}01)$ -preferred orientation with  $p$ -type behavior. Moreover, the  $p$ -type Mg-doped  $\beta$ -Ga<sub>2</sub>O<sub>3- $\delta$</sub>  films have a

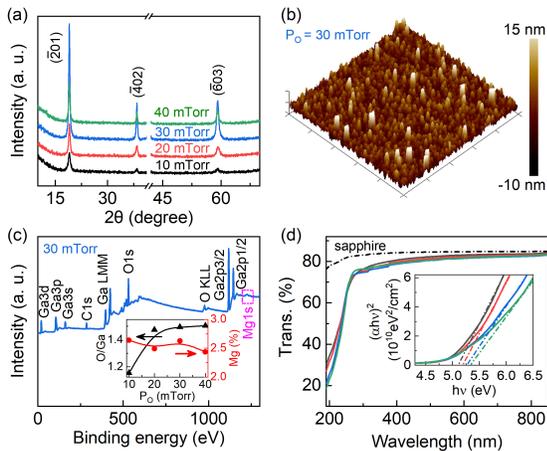
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**Fig. 1.** (a) XRD of the Mg-doped Ga<sub>2</sub>O<sub>3- $\delta$</sub>  films deposited at  $P_O = 10, 20, 30,$  and  $40$  mTorr. (b) The AFM image with a scanning range of  $5 \mu\text{m} \times 5 \mu\text{m}$  and (c) full XPS spectrum of the Mg-doped Ga<sub>2</sub>O<sub>3- $\delta$</sub>  films deposited at  $P_O = 30$  mTorr. Inset: O/Ga and Mg concentration as a function of oxygen partial pressure ( $P_O$ ). (d) Transmittance as well as the  $(\alpha h\nu)^2$  vs.  $h\nu$  (inset) spectra of Mg-doped Ga<sub>2</sub>O<sub>3- $\delta$</sub>  films.

good optoelectronic performance under the UV illumination (254 nm) for solar-blind photodetectors.

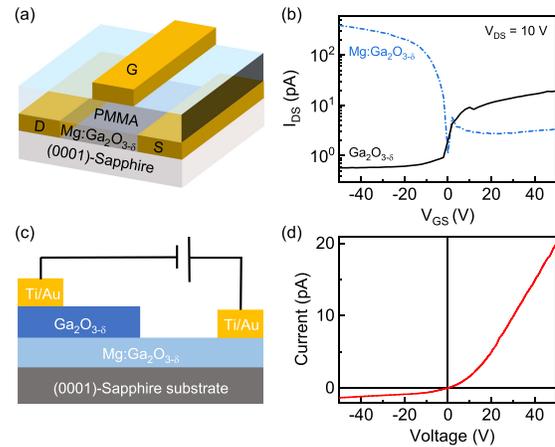
## II. EXPERIMENTAL

The Mg-doped  $\beta$ -Ga<sub>2</sub>O<sub>3- $\delta$</sub>  films were deposited on (0001)-sapphire substrates by the PLD method using a 3% Mg-doped Ga<sub>2</sub>O<sub>3</sub> target. The film deposition temperature is 700 °C, and the oxygen partial pressure ( $P_O$ ) is various from 10 to 40 mTorr. Moreover, the top-gate field effect transistors (FETs) and Mg-doped/undoped Ga<sub>2</sub>O<sub>3- $\delta$</sub>  junctions have been fabricated to detect the conductivity type of the as-deposited films. Finally, two-terminal Mg-doped  $\beta$ -Ga<sub>2</sub>O<sub>3- $\delta$</sub>  based photodetectors have been fabricated.

The crystalline structure, surface morphology, and composition of Mg-doped  $\beta$ -Ga<sub>2</sub>O<sub>3- $\delta$</sub>  films were analyzed by X-ray diffraction (XRD), atomic force microscopy (AFM), and X-ray photoelectron spectroscopy (XPS). The double-beam ultraviolet-infrared spectrophotometer was used to measure the film transmittance in the wavelength range of 190–850 nm. The optoelectrical performance of  $\beta$ -Ga<sub>2</sub>O<sub>3- $\delta$</sub>  based devices were measured by an accurate semiconductor parameter analyzer Keithley 4200-SCS. A UV quartz tube with a pure UV filter was used as the UV light source (254 nm) to probe the photoelectric behavior of solar-blind photodetectors.

## III. RESULTS AND DISCUSSION

In Fig. 1a, the XRD curve feature clearly agrees with the XRD standard card (JCPDS Card: No. 43-1012). There are three peaks nearby 18.9, 38.4, and 59.1°, corresponding to the ( $\bar{2}01$ ), ( $\bar{4}02$ ), and ( $\bar{6}03$ ) crystal planes of  $\beta$ -Ga<sub>2</sub>O<sub>3</sub> with no impurity phase [26]. It indicates that Mg<sup>2+</sup> ions are incorporated into the  $\beta$ -Ga<sub>2</sub>O<sub>3</sub> structure by replacing Ga<sup>3+</sup> ions [26]. The as-deposited films with the ( $\bar{2}01$ )-orientation are polycrystalline. According to the Scherrer's equation [32], the average grain size of the films deposited under  $P_O = 10, 20, 30,$  and  $40$  mTorr are 24.6, 34.3, 36.8, and 35.1 nm, respectively. The Mg-doped Ga<sub>2</sub>O<sub>3- $\delta$</sub>  films ( $P_O = 30$  mTorr)



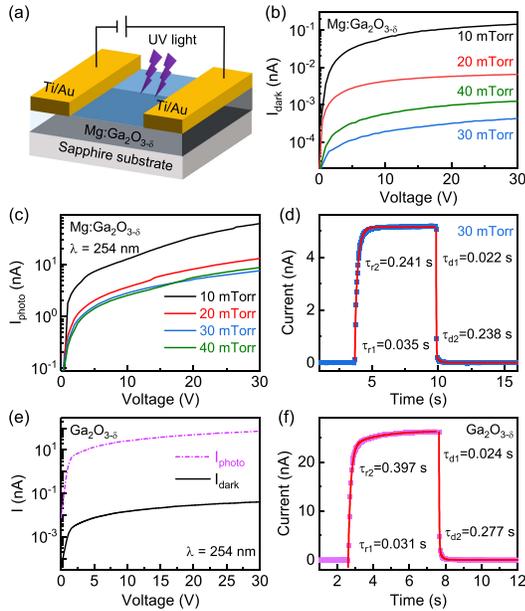
**Fig. 2.** (a) Schematic diagram and (b) transfer characteristic curves of the  $\beta$ -Ga<sub>2</sub>O<sub>3- $\delta$</sub>  based FETs. (c) Schematic diagram and (d) I-V characteristics of the Mg-doped/undoped  $\beta$ -Ga<sub>2</sub>O<sub>3- $\delta$</sub>  p-n junction.

has the largest grain size due to the changes of kinetic energy and mean free path of plasma plume, which is consistent with the results of AFM images (cf., Fig. 1b).

In Fig. 1c, the XPS spectrum of a Mg-doped Ga<sub>2</sub>O<sub>3- $\delta$</sub>  film ( $P_O = 30$  mTorr) reveals that the as-deposited films have a Mg concentration of around 2.5%. The O/Ga ratio values of the films deposited under  $P_O = 10, 20, 30,$  and  $40$  mTorr are about 1.15, 1.47, 1.49, and 1.50, respectively. It means the oxygen vacancies in the films are reduced by increasing the oxygen partial pressure. The transmission spectra show that the transmittance exceeds 80% in the near UV-visible-NIR region, and the absorption edge appears at about 270 nm (cf., Fig. 1d). Note that the absolute average transmittances of the Mg-doped  $\beta$ -Ga<sub>2</sub>O<sub>3- $\delta$</sub>  films will exceed 90% in the transparent region after deducting the influence of sapphire substrates. The optical bandgap of the Mg-doped Ga<sub>2</sub>O<sub>3- $\delta$</sub>  films prepared at  $P_O = 30$  mTorr is about 5.2 eV (238.5 nm) based on the Tauc's relationship [32], as illustrated in the inset of Fig. 1d. It indicates that the present films can be applied in UV photodetectors.

A further step, the conductivity type of the Mg-doped  $\beta$ -Ga<sub>2</sub>O<sub>3- $\delta$</sub>  films has been investigated based on the transfer curves of related FETs (cf., Figs. 2a and 2b). For comparison, pure  $\beta$ -Ga<sub>2</sub>O<sub>3- $\delta$</sub>  based FETs were prepared under the same conditions. As the gate voltage ( $V_{GS}$ ) is swept from  $-60$  to  $+60$  V, there is a process from depletion to accumulation, which indicates that the conductivity type of the pure  $\beta$ -Ga<sub>2</sub>O<sub>3- $\delta$</sub>  films is *n*-type. On the contrary, the transfer response of the Mg-doped  $\beta$ -Ga<sub>2</sub>O<sub>3- $\delta$</sub>  based FETs reveals that the conductivity type of the Mg-doped  $\beta$ -Ga<sub>2</sub>O<sub>3- $\delta$</sub>  films is *p*-type. Furthermore, the Mg-doped/undoped  $\beta$ -Ga<sub>2</sub>O<sub>3- $\delta$</sub>  junctions were fabricated, as illustrated in Fig. 2c. In Fig. 2d, the I-V characteristics of the junctions exhibit a typical rectification characteristic with a rectification ratio of  $30.9 \pm 20$  V, which confirms that the as-deposited Mg-doped  $\beta$ -Ga<sub>2</sub>O<sub>3- $\delta$</sub>  films have *p*-type behavior.

The two-terminal solar-blind photodetectors based on the as-deposited films were fabricated by evaporating 2nm/60nm-thick Ti/Au electrodes to characterize the photoelectric properties of the *p*-type  $\beta$ -Ga<sub>2</sub>O<sub>3- $\delta$</sub>  films (cf., Fig. 3a).

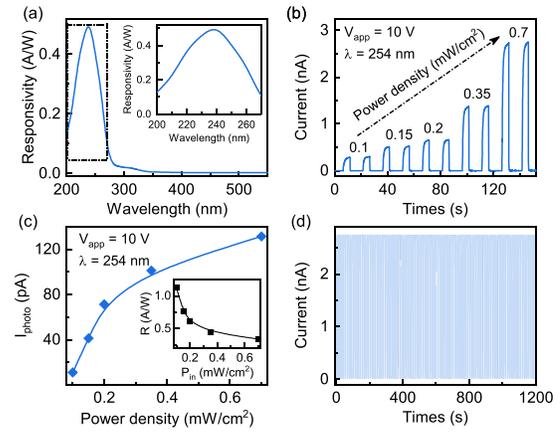


**Fig. 3.** (a) Schematic diagram, (b)  $I_{\text{dark}}-V$ , (c)  $I_{\text{photo}}-V$  at  $\lambda = 254$  nm and (d)  $I-t$  curve of the two-terminal solar-blind Mg-doped  $\beta\text{-Ga}_2\text{O}_{3-\delta}$  based photodetector by applying a single pulsed light at  $V_{\text{app}} = 10$  V. (e)  $I-V$  and (f)  $I-t$  curves of the undoped  $\beta\text{-Ga}_2\text{O}_{3-\delta}$  based photodetector.

In Fig. 3b, the Mg-doped  $\beta\text{-Ga}_2\text{O}_{3-\delta}$  films grown under  $P_{\text{O}} = 30$  mTorr have the lowest dark current ( $I_{\text{dark}}$ ) due to the ideal O/Ga ratio and large grain size, that is, the decrease of oxygen vacancies results in a reduction of carriers. Fig. 3c shows that the photocurrent ( $I_{254\text{nm}}$ ) is almost unchanged for the devices ( $P_{\text{O}} = 20, 30,$  and  $40$  mTorr). For the case of  $P_{\text{O}} = 10$  mTorr, small grain size and more oxygen vacancies result in a large photocurrent [33]. Note that the  $I_{\text{dark}}$  and  $I_{\text{photo}}$  responses suggest that the resistance of Mg-doped  $\text{Ga}_2\text{O}_3$  films is higher than other  $p$ -type  $\text{Ga}_2\text{O}_3$  (e.g.  $\text{Zn:Ga}_2\text{O}_{3-\delta}$ ) due to the overcompensation by oxygen vacancies [34], [35].

The time-dependent photoelectric response tests were carried out by applying a bias voltage ( $V_{\text{app}}$ ) of 10 V, as shown in Fig. 3d. The photocurrent curves have been fitted by the relationship [33]:  $I = I_0 + Ae^{-t/\tau_1} + Be^{-t/\tau_2}$ . Here,  $I_0$  is the steady-state photocurrent,  $A$  and  $B$  are fitting parameters, and  $\tau_1$  and  $\tau_2$  are the relaxation times of the fast and slow response parts of the rise or decay edges, respectively. The fast response part is related to the change of photo-generated carriers, which is determined by the film quality. The slow one is related to the trapped or de-trapped process of carriers. The photodetectors based on the Mg-doped  $\beta\text{-Ga}_2\text{O}_{3-\delta}$  films ( $P_{\text{O}} = 30$  mTorr) have the fastest response speed with rise ( $\tau_{r1} = 0.035 \pm 0.004$  s and  $\tau_{r2} = 0.241 \pm 0.003$  s) and decay ( $\tau_{d1} = 0.022 \pm 0.002$  s and  $\tau_{d2} = 0.238 \pm 0.001$  s) times since the carriers are more difficult to be captured in the high quality films with fewer oxygen vacancies. Compare to the optoelectrical performance of the pure  $\beta\text{-Ga}_2\text{O}_{3-\delta}$  based photodetectors (Figs. 3e and 3f), the Mg-doped  $\beta\text{-Ga}_2\text{O}_{3-\delta}$  based photodetectors have a smaller  $I_{\text{dark}}$ , larger  $I_{\text{photo}}/I_{\text{dark}}$  ratio, and a faster slow-response ( $\tau_{r2}$  and  $\tau_{d2}$ ) due to the fewer oxygen vacancies.

To further illustrate the optoelectrical performance of Mg-doped  $\beta\text{-Ga}_2\text{O}_{3-\delta}$  based solar-blind photodetectors, the device responsivity ( $R$ ) has been studied, which is defined as



**Fig. 4.** (a) Response spectra of the photodetectors based on the Mg-doped  $\beta\text{-Ga}_2\text{O}_{3-\delta}$  film ( $P_{\text{O}} = 30$  mTorr) as a function of illumination wavelength. (b)  $I_{\text{photo}}-t$  at different pulsed light power densities. (c) Photocurrent and responsivity ( $R$ ) of the two-terminal photodetectors as a function of light power density ( $P_{\text{in}}$ ). (d) Dynamic response of the Mg-doped  $\text{Ga}_2\text{O}_3$  based solar-blind photodetectors under on/off modulated UV light (254 nm,  $0.7$  mW/cm<sup>2</sup>).

$R = I_{\text{photo}}/(P_{\text{in}} \times S)$ . Here,  $I_{\text{photo}}$  is the photocurrent,  $P_{\text{in}}$  is the power density of the incident light, and  $S$  is the effective working area of the device [17]. As a solar-blind photodetector, the response spectra are shown in Fig. 4a. It reveals that the device response wavelength range is about 200-270 nm, which is consistent with the optical bandgap  $E_g$  derived from the transmittance spectra (cf., Fig. 1d). Fig. 4b shows that the photocurrent increases with increasing the power density of the incident UV light (254 nm) due to the more photogenerated carriers. The photodetector responsivity ( $R$ ) decreases with increasing the light power density since the photocurrent becomes saturated (cf., Fig. 4c). In Fig. 4d, a stability test were carried out by applying a voltage of  $V_{\text{app}} = 10$  V and UV pulsed light (254 nm,  $0.7$  mW/cm<sup>2</sup>, and more than 50 periods), which indicates that the present photodetectors have good stability and repeatability.

#### IV. CONCLUSION

In summary,  $p$ -type Mg-doped  $\beta\text{-Ga}_2\text{O}_{3-\delta}$  films with the  $(\bar{2}01)$ -orientation have been deposited on  $(0001)$ -sapphire substrates under various oxygen partial pressures ( $P_{\text{O}} = 10\text{--}40$  mTorr) and the optimum pressure is 30 mTorr. A further step, the conductivity type of Mg-doped  $\beta\text{-Ga}_2\text{O}_{3-\delta}$  films is proved to be  $p$ -type obtained from the Mg-doped  $\beta\text{-Ga}_2\text{O}_{3-\delta}$  based FETs and Mg-doped/undoped  $\beta\text{-Ga}_2\text{O}_{3-\delta}$  junctions. Furthermore, it has been found that the photodetectors based on the Mg-doped  $\beta\text{-Ga}_2\text{O}_{3-\delta}$  films ( $P_{\text{O}} = 30$  mTorr) exhibit the optimum optoelectrical performance with a low dark current of  $0.19$  pA at 10 V, a high  $I_{254\text{nm}}/I_{\text{dark}}$  ratio of  $1.3 \times 10^4$ , fast rise ( $\tau_{r1} = 0.035 \pm 0.004$  s and  $\tau_{r2} = 0.241 \pm 0.003$  s) and decay ( $\tau_{d1} = 0.022 \pm 0.002$  s and  $\tau_{d2} = 0.238 \pm 0.001$  s) times, which exhibit good stability and repeatability.

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